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Abstract. Raman scattering is a nondestructive technique that is able to supply information on the crystal and electronic structures, strain, temperature, phonon–phonon, and electron–phonon interaction. In the particular case of semiconductor nanowires, Raman scattering provides additional information related to surfaces. Although correct, a theoretical approach to analyze the surface optical modes loses critical information when retardation is neglected. A comparison of the retarded and unretarded approaches clarifies the role of the electric and magnetic polarization in the Raman selection rules. Since most III–V compounds growing in the zincblende phase change their crystal structure to wurtzite when growing as nanowires, the polariton description will be particularized for these two important crystal phases. Confined phonons exist in cylindrical nanowires and couple with longitudinal and transverse modes due to the presence of the nanowire’s surface. This coupling vanishes in the case of rotational symmetry. The boundary conditions of the electromagnetic fields on small-size nanowires (antenna effect) have a dramatic effect on the polarization properties of a Raman spectrum. © 2013 Society of Photo-Optical Instrumentation Engineers (SPIE) [DOI: [10.1117/1.JNP.7.071598](https://doi.org/10.1117/1.JNP.7.071598)]

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1 Introduction

Nanowires (NWs) are quasi-one-dimensional (1-D) materials where one of the dimensions, usually in the 10- to 100-nm range, is much smaller than the other two (in the range of a few microns). They were first called nanowiskers, but they have received other names in the literature such as nanorods or nanocolumns. They can be made of metals, polymers, or semiconductors, and the most common cross-sections are nearly cylindrical, hexagonal, triangular, or squared. The NW geometry has several advantages as compared to quantum wells or quantum dots, the most elemental one being the large surface-to-volume ratio as compared to a thin film (additional contribution of the lateral surface). Depending on the density and cross-section, an NW bunch can have 100 times more surface than a thin film of the same dimensions. This fact can be useful in the development of solar cells or chemical sensors.¹ On the other hand, new concepts of heterostructures arise from the NW shape, like core/shell or axial heterostructures (quantum dots in a wire). Core/shell nanostructures can be particularly useful in the development of solar cells,² while axial heterostructures are suitable for quantum computing.³

Semiconductor NWs can be grown by chemical vapor deposition, chemical beam epitaxy, or molecular beam epitaxy.^{4–6} Usually, they are grown using gold as a catalyst,⁷ but depending on the semiconductor, they can also be grown without a catalyst.⁵ They are commonly grown on a convenient substrate like Si or GaAs, which can be prepatterned in order to develop ordered NW arrays.¹ Due to the existence of a free surface, heterostructures can be grown with larger lattice mismatch than superlattices or quantum wells.⁸ The reason is the relaxation of the structure at the sample surface.⁹ In very thin NWs, the fact that the bond distances close to the surface are larger due to relaxation effects produces changes in the electronic band structure of the material. NWs

have a huge amount of applications—in photonic as light emitting diodes or lasers, solar cells, as energy harvesting materials,^{1,2} in transport as single-electron transistors,^{3,10} or in phototransport devices.^{11,12}

One more particularity of semiconductor NWs is the fact that the balance between surface energy and bulk energy gives rise to new crystal structures, not stable when grown in bulk systems. In particular, most of the III–V semiconductors crystallizing in the zincblende (ZB) structure in bulk develop the wurtzite (WZ) structure when growing in the form of NWs;⁷ actually, very often, ZB stacking faults appear within the WZ structure. A recent experiment on InAs NWs photoluminescence¹³ shows the existence of two bands in the emission at low temperatures, presumably one with origin in the ZB region and a second from the WZ region. From this variation, an energy gap of 2.45 eV for the E_1 gap of InAs has been obtained. This value is in very good agreement with resonant Raman measurements¹⁴ and *ab initio* calculations.¹⁵ High-resolution transmission electron microscopy images clearly show the existence of these two regions. The same behavior has been observed in other semiconductors, like InP.⁶ A detailed band structure calculation in the WZ phase has been performed in these two compounds.^{15,16}

Figure 1 shows a set of InN NWs grown by molecular beam epitaxy under different temperatures, nitrogen flux, and In vapor pressure conditions. We can observe how the shape of the NWs can be completely different depending on the growth conditions.

Finally, the electronic bands bend at the surface of the NWs as in any surface in a solid, but in the case of an NW the effect is more notable due to the large contribution of the surface compared to the inner part of the NW. Although the origin is not completely clear, some NW semiconductors have a depletion layer at the surface, some others an accumulation layer.^{5,17} The accumulation layer influences both the optical¹⁸ and transport properties.¹⁹

In this first work, we will focus on the theoretical development of the Raman theory, first in bulk and then particularizing for the case of NWs. In a second work, we will pay more attention to the comparison of the existing theories with the available experimental results.

Fig. 1 Indium nitride NW morphologies obtained under varied metal flux and substrate temperature (thermocouple temperature using the $1 \times 1 \text{ cm}^2$ with $8.88 \times 8.88 \text{ mm}^2$ opening) and constant growth time of 300 min and nitrogen flux $F_N = 2 \text{ sccm}$ (cc/min at 0°C at 1 atm of pressure) and a plasma excitation power $P_N = 500 \text{ W}$, which corresponds to a growth rate at stoichiometry of $\sim 12.5 \text{ m/min}$. Arrows indicate the modifications produced with the increase of the substrate temperature T_s . (The author thanks Dr. Christian Denker for providing some SEM images of his PhD dissertation.)

2 Raman Scattering

In a semiconductor, most of the incident radiation is either reflected, absorbed, or transmitted; only a small amount is scattered. The elastically scattered light is called Rayleigh scattering. Actually, the elastic scattering is possible due to the existence of defects in the sample; in a nearly perfectly grown material with translational symmetry, the elastic scattering must be very low.^{20,21} A tiny amount of the scattered light, in general several orders of magnitude smaller than that scattered elastically, corresponds to inelastic light scattering or Raman scattering.

The Raman effect or light scattering was predicted by Smekal in 1923 (Ref. 22) and measured simultaneously by Landsberg and Mandelstam,²³ and by Raman and Krishnan²⁴ in solids and liquids, respectively. Actually, the first set of authors discovered the effect previously, but the publication of the second set of authors appeared earlier in 1928. For this discovery, Raman was the Nobel laureate in physics in 1930. Raman was the only Third-World scientist who received the Nobel laureate for a research performed in an undeveloped country.

Although the Raman effect is understood usually as the scattering of light due to phonons, any kind of inelastic light scattering is called Raman scattering. The scattering by electronic excitations or magnetic excitations are also Raman scattering. In this review, we are going to limit the analysis to the Raman scattering by phonons. The classical theory of the Raman effect was developed by the same authors who discovered the effect, Mandelstam et al.,²⁵ and the quantum theory by Tamm.²⁶ A rigorous development of the classical theory can be found in the book of Born and Huang.²⁷ We will follow here the development of Cantarero et al.^{28,29} and Trallero-Giner et al.³⁰

In the infrared, there is a direct coupling of the electric field of the light with the phonons, but in Raman scattering, the coupling is via virtual electronic states, as it was shown many years ago by Loudon.³¹ If the semiconductor gap is around the energy of the laser or scattered light, the transition between electronic states becomes real and the Raman signal increases orders of magnitude. In that case, we have to take into account the width of the electronic states, and the process is usually referred as resonant Raman scattering (RRS).²⁸ Double and triple resonances (multiple resonances with several electronic levels) can also increase, additionally, the scattering signal.³² Electric fields,³³ magnetic fields,³⁴ or high pressure³⁵ can also be tuned to produce RRS. Excitons play an important role in first-order RRS (Ref. 28) or Raman scattering by one phonon. In second-order RRS (scattering by two phonons at the Γ -point), excitons also play a fundamental role in the resonant behavior³⁶ because the intermediate excitonic state can also resonate. Electron–phonon interaction is thus the crucial part of the resonant process, since there is a direct interaction between the electrons and the phonons, even out of resonance. Electron–phonon interaction is actually very important within the electronic transitions itself since it renormalizes the electronic gap of the materials³⁷ and gives a broadening to the electronic states. Also, when the electrons have enough energy to emit optical phonons, the photoluminescence processes become more efficient since the emission probability increases. Electron–phonon interaction is important not only in optics but also in transport, through the different relaxation mechanisms.³⁸

The laser wavelength or laser energy is the other crucial part of the resonant process, since the variation of the laser energy approaching the electronic transition is the basis of the RRS. As an example, the Raman signal of strontium titanate/barium titanate (STO/BTO) quantum wells when illuminated with visible light was not good enough to even see the Raman signal. But ultraviolet light has been shown to be very efficient for analyzing STO/BTO quantum wells constituted even by a single layer³⁹ due to resonance effects. In single wires, since there is a small amount of material, resonant effects are very important¹⁵ to make the Raman effect observable.

In nonpolar semiconductors, there is no splitting between the the transverse (TO) and longitudinal (LO) optical phonons, but in polar semiconductors like GaAs, there is a splitting related to the difference between the low- and high-frequency dielectric permittivities (or the effective charges). The splitting is a measure of the polarity of the semiconductor. In polar semiconductors, plasmons interact with LO phonons giving rise to an anticrossing when the plasma frequency coincides with the LO phonon frequency, which depends on the electron concentration.⁴⁰ From the measurement of the two split frequencies, the electron concentration

can be obtained.⁴⁰ In heavily doped samples, the electronic background is of the order of the Raman signal; electrons interact strongly with the phonons giving rise to the Fano lineshape,^{40,41} produced by the sum of quantum probabilities of the two processes, which can have opposite signs. Since phonons depend on the mass of the ions, Raman scattering has been used in the last years to study the isotopic composition of isotopically engineered samples^{42–44} and phonon anharmonicities.⁴⁵ Phonons are also sensitive to pressure or stress variations.^{46,47} In thin films and semiconductor nanostructures, Raman scattering is used very often to obtain the lattice mismatch through the phonon deformation potentials.⁴⁸

Recently, with the advances in the fabrication of holographic filters (notch or edge filters), a single spectrometer is enough to study the Raman scattering in most of the materials. A good holographic filter has a cutoff of $\sim 100 \text{ cm}^2$, or even less. There are, in the market, several companies selling compact instruments, smaller than a shoebox, completely equipped connectable to a portable computer capable of obtaining reasonable Raman scattering signals at a competitive price. If we need to study phonon modes at lower frequencies, a double or triple spectrometer, in subtractive mode, is needed. Also, if we need to increase the resolution because the phonon lines are narrow, we can use a triple spectrometer in additive mode and lower the temperature to decrease the phonon anharmonicities. Most of the Raman systems are equipped with a charged coupled device, but if we really need resolution, we have to go back to the photomultipliers. In the book of Kuzmany,⁴⁹ there is a complete description of the apparatus used in Raman scattering: spectrometers, gratings, and detectors.

During the last decades, part of the scientific community has been dedicated to characterize, by Raman scattering, thin films, quantum wells, quantum dots, quantum wires, or even more complex nanostructures.⁵⁰ In the simple case of a thin film, if we use the typical collection, a photographic camera objective, producing a laser spot $\sim 10 \text{ }\mu\text{m}$, most of the Raman signal will come from the substrate and it can mask the really important signal. We need, in that case, the use of a microscope (micro-Raman or μ -Raman system), where the laser spot can be $< 1 \text{ }\mu\text{m}$ (with a confocal microscope, we can go to the diffraction limit⁵⁰). However, the use of a microscope has a couple of disadvantages. First, all the light, including the reflected light, goes through the entrance slit of the spectrometer (unless we use a notch or edge filter). The second disadvantage is that the selection rules are not completely fulfilled. If we have an objective of $100\times$ and a numerical aperture⁵⁰ $\text{NA} = 0.9$, such as that shown in Fig. 2(a), the entrance angle with a refractive index of 3 (a typical value for semiconductors) will be $\sim 17.5^\circ$. In a typical μ -Raman system, a confocal microscope is employed in order to perform the measurements on a specific point of the sample (below $1 \text{ }\mu\text{m}$ in lateral resolution and 100 nm in depth). A confocal microscope and a motorized xyz plate allow the mapping of small areas at different depths. In Fig. 2(b), there is a scheme of a confocal system where we observe how the light enters into a sample with a smaller angle due to the difference of refractive indices. Although we do not have a complete backscattering geometry, the selection rules are fulfilled to a great extent due to the difference in refractive index.

3 Scattering Efficiency

In order to compare the Raman signal or the Raman intensity of different materials, it is convenient to use the Raman scattering efficiency (RSE), instead of the scattering cross-section, since the first amount is volume independent. In a polar binary compound semiconductor, the RSE per unit solid angle Ω can be defined as²⁸

$$\frac{dS}{d\Omega} = \frac{\omega_S^3 \omega_L}{c^4} \frac{\hbar}{2v_c \mu \omega_\Gamma} \frac{n_S}{n_L} |e_L \mathcal{R}_\Gamma e_S|^2 [N(\omega_\Gamma) + 1], \quad (1)$$

where c is the speed of light in vacuum, μ the reduced mass of the ions, v_c the volume of the unit cell, ω_L (ω_S) the laser (scattering) angular frequency, n_L (n_S) the refractive index at the laser (scattered) frequency, ω_Γ the angular frequency of the corresponding phonon, e_L (e_S) the polarization vector of the laser (scattered) light, and $\mathcal{R}_\Gamma$ the Raman tensor corresponding to the Γ phonon mode. The factor $N(\omega_\Gamma) + 1$ has its origin in a quantum mechanical description of the phonon field,²⁸ and it corresponds to the phonon emission (Stokes shift). In the case of

Fig. 2 (a) Cross-section of an objective (by courtesy of Carl Zeiss Microscopy, Germany). 1. Objective thread. 2. Stop face of the objective. 3. Spring system for the specimen-protection mechanism. 4. to 7. Lens groups for the correction of image errors. 8. Correction collar for adapting to deviating cover glass thicknesses or temperatures. 9. Front lens system. 10. Front lens holder. (b) Schematic representation of a confocal setup, where we can observe the angle change inside the sample due to the differences in refractive indices.

phonon absorption (anti-Stokes shift or anti-Stokes scattering), the factor is $N(\omega_\Gamma)$. In practice, this factor is replaced by the Bose–Einstein distribution function, and this is the reason why at the anti-Stokes frequency, the Raman scattering signal is very weak as compared to that appearing at the Stokes shift, unless the temperature is very high. In a classical description, both Stokes and anti-Stokes components have the same intensity. An exception is stimulated Raman scattering, where phonons at the anti-Stokes frequency⁵⁰ are excited. For Stokes shift, even if $N(\omega_\Gamma) \sim 0$, the factor 1 remains and the Stokes shift can be observed at any temperature. The relative intensity of the Stokes/anti-Stokes Raman shift can be used to monitor the temperature.⁵¹

The Raman tensor is a second-order tensor, sometimes written as a third-order tensor (or even as a fourth-order tensor⁵²) contracted with the phonon polarization ($R_{ij}^k \hat{q}_k$, where $\hat{q}$ is a unitary vector in the direction of the phonon displacement). The form of the Raman tensor depends on the symmetry of the crystal and the electron–phonon interaction, since in the Raman effect, electrons play a crucial role as virtual intermediate states in the Raman process.³¹ For an LO phonon propagating along x ([1,0,0]) direction, the Raman tensor for the optical modes of a ZB crystal can be written in terms of the Raman polarizability α as

$$\mathcal{R}_{\text{LO}}^x = \begin{pmatrix} 0 & 0 & 0 \\ 0 & 0 & \alpha \\ 0 & \alpha & 0 \end{pmatrix}, \quad (2)$$

and it is observable in the $x(y, z)\bar{x}$ scattering configuration written in Porto's notation.⁵³ Actually, we can write $R_{yz}^x = R_{zy}^x = \alpha$. The remaining nonzero Raman tensor components are $R_{xz}^y = R_{zx}^y = R_{xy}^z = R_{yx}^z = \alpha$. We will come back to this point in Sec. 4. The Raman polarizability has the expression⁵⁴

$$\alpha = \frac{n_L n_S}{2\pi} \frac{v_c}{\bar{u}_\Gamma} \frac{1}{\hbar \omega_L} W_{\text{FI}}(\omega_L, e_L, \omega_S, e_S), \quad (3)$$

where the relative phonon displacement $\bar{u}_\Gamma$ is defined by the expression

$$\bar{u}_\Gamma^2 = \frac{\hbar v_c}{2V\mu\omega_\Gamma}, \quad (4)$$

and $W_{FI}(\omega_L, e_L, \omega_S, e_S)$ is the amplitude probability of scattering of a phonon with wave number ω_Γ . The remaining quantities have been defined already. The amplitude probability

$$W_{FI} = \sum_{\nu, \nu'} \left[\frac{\langle I | H_{eR} | \nu \rangle \langle \nu | H_{eL} | \nu' \rangle \langle \nu' | H_{eR} | F \rangle}{(\hbar\omega_L - E_\nu + i\gamma_\nu)(\hbar\omega_S - E_{\nu'} + i\gamma_{\nu'})} \right], \quad (5)$$

where the $\delta(E_F - E_I)$ of the Fermi golden rule has already been taken into account. This amplitude probability corresponds to the Feynmann diagram given in Fig. 3. The remaining five terms or Feynmann diagrams³¹ are nonresonant, and they can be neglected. E_μ (E_ν) and γ_μ (γ_ν) are the energy and broadening of the electronic states (which can be accessed in a time-resolved Raman experiment⁵⁵). If there are several initial and/or final states (as it is the case of several valence bands in a ZB or WZ compound), we have to sum over I, F after squares W_{FI} . The sum over intermediate states is performed before squaring the expression. H_{eR} and H_{eL} are the electron-radiation and electron(hole)-phonon Hamiltonians, which can be written in the second quantization formalism.²⁸ The important point is the electron–phonon coupling constant, which consists of two parts, one corresponding to the emission of the phonon by the electron (see Feynmann diagram in Fig. 3) and a second corresponding to the emission of the phonon by the hole. In ZB- (and WZ-) type materials, only the second option is nonzero, and the electron–phonon coupling constant is

$$S_{\nu\nu'}^{KK-q}(q) = -\frac{\bar{u}_\Gamma \sqrt{3}}{2a_0} D_h(r) I_{\nu\nu'}(q), \quad (6)$$

where $D_h(r)$ is the deformation potential (DP) matrix as defined by Bir and Pikus.⁵⁶ In the case of the Fröhlich interaction,³⁰ the basic expressions are the same; the only change is in the electron–phonon interaction Hamiltonian. Its coupling constant, in that case, is³⁰

$$S_{\nu\nu'}^{KK-q}(q) = \frac{1}{\sqrt{V}} \frac{C_F^*}{q} [I_{\nu\nu'}(-q_h) - I_{\nu\nu'}(q_e)], \quad (7)$$

where the Fröhlich constant

$$C_F = -ie \sqrt{2\pi\hbar\omega_\Gamma \left(\frac{1}{\epsilon_\infty} - \frac{1}{\epsilon_0} \right)} \quad (8)$$

and $q_\zeta = qm_\zeta/(m_e + m_h)$ ($\zeta = e, h$). Since Fröhlich is intraband (there is also an interband Fröhlich interaction with upper conduction bands—the electro-optic effect), we have to consider both contributions, that of the electron and that of the hole. We cannot do the dipole approximation ($\kappa_L \approx \kappa_S \approx 0$) here, and the absolute value of q must be taken into account. The Raman tensor for Fröhlich interaction is diagonal.

Fig. 3 Feynmann diagram corresponding to the Raman process described above.

$$\mathcal{R}_F = \begin{pmatrix} \alpha_F & 0 & 0 \\ 0 & \alpha_F & 0 \\ 0 & 0 & \alpha_F \end{pmatrix}. \quad (9)$$

It is interesting to realize that the DP is a local interaction, and thus it is related to the periodic part of the Bloch function, while the Fröhlich interaction, only possible in polar materials, is a long-range interaction related to the polarization charges in the medium, and only the envelope of the Bloch function contributes to the matrix element.³⁰ On the other hand, since both processes are possible in the case of LO phonons, the amplitude probability must be added before squaring it, and interference effects can appear²⁹ when the Raman polarizabilities corresponding to deformation potential (DP) and Fröhlich interaction are of the same order of magnitude, i.e., close to an electronic transition, in resonance. This is the reason we usually say that the selection rules are not completely fulfilled in resonance. During many years, the huge enhancement of Raman scattering close to the gap could not be explained, and it was attributed to unknown values of one of the constants that appear in the expression of RSE or to the existence of impurity-induced Raman scattering.⁵⁷ Finally, it was demonstrated that the consideration of excitons, instead of electrons,³¹ as intermediate states in the Raman process could explain the absolute value of Raman scattering in the case of deformation potential,²⁸ Fröhlich interaction,³⁰ and also the interference between both.²⁹ The interference is produced due to the fact that we have to add the probabilities before squaring (they correspond to different intermediate steps).

4 Raman Tensor and Raman Selection Rules

In Sec. 3, the Raman tensor of an LO phonon propagating along the [100] direction of the ZB structure was defined in Eq. (2). We also defined the remaining components of the Raman tensor using the conventional unitary vectors along x , y , and z . If one is interested in a different crystal surface, a general method to proceed is to define the following three vectors:⁵⁸

$$a_1 = (h, k, l), \quad (10)$$

defining the crystal surface where the Miller indices are normalized ($h^2 + k^2 + l^2 = 1$). The two perpendicular vectors forming a right-handed coordinate system are

$$a_2 = (-k, h, 0)/\sqrt{h^2 + k^2}; \quad a_3 = (-hl, -kl, h^2 + k^2)/\sqrt{h^2 + k^2}. \quad (11)$$

It is also convenient to define the matrix formed by these three vectors written in rows.

$$\mathcal{A} = \begin{pmatrix} h & k & l \\ \frac{-k}{\sqrt{h^2 + k^2}} & \frac{h}{\sqrt{h^2 + k^2}} & 0 \\ \frac{-hl}{\sqrt{h^2 + k^2}} & \frac{-kl}{\sqrt{h^2 + k^2}} & \frac{h^2 + k^2}{\sqrt{h^2 + k^2}} \end{pmatrix}. \quad (12)$$

Following Fig. 4, the a_1 axis will be always along the x direction, i.e., the incoming wave vector of the light κ_L and outgoing κ_S are along a_1 . The phonon wave vector q , in backscattering configuration, will also be directed along a_1 . Thus, the LO phonon will vibrate in the a_1 direction, while the two TO phonons will vibrate along the a_2 and a_3 directions. The three vectors are unitary. As commented in Sec. 3, the Raman intensity will be proportional to

$$|e_L(\mathcal{R}\hat{q})e_S|^2. \quad (13)$$

In the case of an LO phonon, the Raman intensity will be proportional to

$$|e_L\mathcal{R}_{LO}e_S|^2, \quad (14)$$

while in the case of TO phonons, the intensity will be proportional to

Fig. 4 Fix axes system, where we have chosen z as the direction of the cylinder axis, x as the direction of the light in backscattering configuration, and y as the perpendicular direction, forming a right-handed system. The vectors e_L and e_S indicate the polarization of the incoming and scattered light, respectively, and θ and ϕ the corresponding angles of rotation, with origin in the z axis with counterclockwise rotation.

$$|e_L \mathcal{R}_{\text{TO}_1} e_S|^2 + |e_L \mathcal{R}_{\text{TO}_2} e_S|^2. \quad (15)$$

The reason of summing after squaring is that these are two different final states, but since they appear at the same energy when looking at the Stokes shift, we have to add the intensities. Of course, depending on the selection rules for a given surface, only one of them can contribute. In the case of the ZB structure, it is very simple to calculate the resulting intensity for a $(1\bar{1}0)$ surface, for instance. In that case,

$$\mathcal{A} = \begin{pmatrix} \frac{1}{\sqrt{2}} & -\frac{1}{\sqrt{2}} & 0 \\ \frac{1}{\sqrt{2}} & \frac{1}{\sqrt{2}} & 0 \\ 0 & 0 & 1 \end{pmatrix}. \quad (16)$$

If the polarization vectors e_L and e_S are both along the (110) direction, the transformed vectors

$$e'_L = \mathcal{A}^\dagger e_L = (100) \quad \text{and} \quad e'_S = \mathcal{A}^\dagger e_S = (100) \quad (17)$$

are along the x direction. The transformed Raman matrix $\mathcal{R}'_i = \mathcal{A}^\dagger \mathcal{R}_i \mathcal{A}$.

$$\mathcal{R}'_1 = \begin{pmatrix} 0 & 0 & \frac{1}{\sqrt{2}} \\ 0 & 0 & \frac{1}{\sqrt{2}} \\ \frac{1}{\sqrt{2}} & \frac{1}{\sqrt{2}} & 0 \end{pmatrix}; \quad \mathcal{R}'_2 = \begin{pmatrix} 0 & 0 & \frac{1}{\sqrt{2}} \\ 0 & 0 & -\frac{1}{\sqrt{2}} \\ \frac{1}{\sqrt{2}} & -\frac{1}{\sqrt{2}} & 0 \end{pmatrix}; \quad \mathcal{R}'_3 = \begin{pmatrix} 1 & 0 & 0 \\ 0 & -1 & 0 \\ 0 & 0 & 0 \end{pmatrix}. \quad (18)$$

The Raman matrices multiplied by the phonon polarization, $\mathcal{R}'_i a_i$,

$$\mathcal{R}'_{\text{LO}} = \begin{pmatrix} 0 & 0 & 0 \\ 0 & 0 & 1 \\ 0 & 1 & 0 \end{pmatrix}; \quad \mathcal{R}'_{\text{TO}_1} = \begin{pmatrix} 0 & 0 & 1 \\ 0 & 0 & 0 \\ 1 & 0 & 0 \end{pmatrix}; \quad \mathcal{R}'_{\text{TO}_2} = \begin{pmatrix} 1 & 0 & 0 \\ 0 & -1 & 0 \\ 0 & 0 & 0 \end{pmatrix} \quad (19)$$

in units of the Raman polarizability. The final result is $|e'_L \mathcal{R}'_{\text{LO}} e'_S|^2 = 0$, $|e'_L \mathcal{R}'_{\text{TO}_1} e'_S|^2 = 0$, $|e'_L \mathcal{R}'_{\text{TO}_2} e'_S|^2 = \alpha_{\text{TO}}$. It is simple to check that, for $e_L = e_S = (1, 1, 1)/\sqrt{3}$, the result is

$|e'_L \mathcal{R}'_{LO} e'_S|^2 = 0$, $|e'_L \mathcal{R}'_{TO_1} e'_S|^2 = 8/9\alpha_{TO}$, and $|e'_L \mathcal{R}'_{TO_2} e'_S|^2 = 4/9\alpha_{TO}$ (the total contribution of the TO is $4/3\alpha_{TO}$). The LO mode is forbidden for this configuration. These results are identical as that given by Cardona.⁵²

Although we have given a general procedure, we will pay particular attention to the case where one of the axis is along the $[111]$ direction, the NW growth direction or the cylinder axis. The reason is that this is the equivalent to the $[0001]$ direction of the WZ structure and the results can somehow be compared. Figure 4 shows the coordinate system where the NW axis is along the laboratory z direction. In that case, it is better to select $\mathcal{A}$ as

$$\mathcal{A} = \begin{pmatrix} \frac{1}{\sqrt{2}} & \frac{-1}{\sqrt{2}} & 0 \\ \frac{1}{\sqrt{6}} & \frac{1}{\sqrt{6}} & \frac{-2}{\sqrt{6}} \\ \frac{1}{\sqrt{3}} & \frac{1}{\sqrt{3}} & \frac{1}{\sqrt{3}} \end{pmatrix} \quad \text{and} \quad \mathcal{A} = \begin{pmatrix} \frac{1}{\sqrt{6}} & \frac{1}{\sqrt{6}} & \frac{-2}{\sqrt{6}} \\ \frac{-1}{\sqrt{2}} & \frac{1}{\sqrt{2}} & 0 \\ \frac{1}{\sqrt{3}} & \frac{1}{\sqrt{3}} & \frac{1}{\sqrt{3}} \end{pmatrix} \quad (20)$$

for $(1\bar{1}0)$ and $(11\bar{2})$ surfaces, respectively. For a $(1\bar{1}0)$ surface, if $e_L = e_S = (1, 1, -2)/\sqrt{6}$, $|e'_L \mathcal{R}'_{TO_1} e'_S|^2 = 2/3\alpha_{TO}$, $|e'_L \mathcal{R}'_{TO_2} e'_S|^2 = 1/3\alpha_{TO}$, i.e., the contribution of the TO mode is α_{TO} , while the LO mode does not contribute. If $e_L = e_S = (1, 1, -2)/\sqrt{6}$, the contribution of $|e'_L \mathcal{R}'_{TO_2} e'_S|^2 = 4/3\alpha_{TO}$. As is well known, the LO phonon is forbidden in the case of a $(1\bar{1}0)$ surface in a ZB material. If $e_L = e_S = (1, 1, 0)/\sqrt{2}$, $|e'_L \mathcal{R}'_{LO} e'_S|^2 = 2/3\alpha_{LO}$ and $|e'_L \mathcal{R}'_{TO_2} e'_S|^2 = 2/3\alpha_{TO}$. In the case where $e_L = e_S = (1, 1, 1)/\sqrt{3}$, $|e'_L \mathcal{R}'_{TO_2} e'_S|^2 = 4/3\alpha_{TO}$. For crossed polarizations, $|e'_L \mathcal{R}'_{LO} e'_S|^2 = 1/3\alpha_{LO}$.

Polar plots can be drawn by considering, in the case of $(1\bar{1}0)$ surfaces, in agreement with Fig. 4,

$$\begin{aligned} e_L(\theta) &= \frac{1}{\sqrt{3}}(1, 1, 1) \cos \theta - \frac{1}{\sqrt{6}}(1, 1, -2) \sin \theta \\ e_S(\phi) &= \frac{1}{\sqrt{3}}(1, 1, 1) \cos \phi - \frac{1}{\sqrt{6}}(1, 1, -2) \sin \phi. \end{aligned} \quad (21)$$

In the WZ structure, there are nine optical modes, but two of them are silent modes. The seven Raman active optical modes are drawn in Fig. 5. The first mode vibrates along the z direction of the WZ structure. The Raman tensor is

$$\mathcal{R}(A_1) = \begin{pmatrix} a & 0 & 0 \\ 0 & a & 0 \\ 0 & 0 & b \end{pmatrix}. \quad (22)$$

The 1-D A_1 mode is a polar mode, with a different polarizability when propagating in the z direction or in the xy plane. As stated before, group theory gives only the difference in anisotropy (a and b polarizabilities), but does not consider the LO – TO splitting, which is due to the polarity of the medium. The two-dimensional (2-D) E_1 modes are also polar modes, with Raman tensor

$$\mathcal{R}[E_1(x)] = \begin{pmatrix} 0 & 0 & c \\ 0 & 0 & 0 \\ c & 0 & 0 \end{pmatrix}; \quad \mathcal{R}[E_1(y)] = \begin{pmatrix} 0 & 0 & 0 \\ 0 & 0 & c \\ 0 & c & 0 \end{pmatrix}. \quad (23)$$

When propagating along x , $E_1(x)$ will be LO, while it will be TO if it propagates along y . There are actually two bidimensional E_1 modes, but one of them corresponds to two acoustic modes, the third acoustical mode being a 1-D A_1 mode. There are also two nonpolar bidimensional E_2 modes, as can be observed in Fig. 5. Both modes actually mix, but the amplitude of the heavier (lighter) atom dominates in the E_{2l} (E_{2h}) modes, vibrating at lower (higher) frequency. The corresponding Raman tensor can be written as

Fig. 5 Raman allowed phonon modes in wurtzite-type crystals. The A_1 mode is 1-D while the E modes are 2-D

$$\mathcal{R}(E_2) = \begin{pmatrix} d & d & 0 \\ d & -d & 0 \\ 0 & 0 & 0 \end{pmatrix}. \quad (24)$$

The WZ is an anisotropic structure. At this point, it is interesting to remark that there are two kinds of anisotropic structures. In the first one, the crystal anisotropy dominates,^{59,60} actually $\epsilon_{\parallel}$ is very different from $\epsilon_{\perp}$. This is the case of most of the layered compounds,⁴⁶ or nonpolar compounds like graphite, but the most common case is that where the Coulomb interaction dominates.³⁵ This is the case of III–V compounds grown in the WZ structure. In recent cases where typical ZB crystals grow in the WZ structure, the material anisotropy is unknown, but, on one side, we know the LO – TO splitting, i.e., the intensity of the Coulomb interaction, and on the other side, a small difference is expected in the crystal anisotropy since the structures are identical until second neighbors. This is very important when we want to draw polar plots in the case of WZ materials. When we rotate the polarization, the polar modes are mixed.

$$\omega_{\text{LO}}^2 = \omega_{A_1(\text{LO})}^2 \cos^2 \theta + \omega_{E_1(\text{LO})}^2 \sin^2 \theta \quad \omega_{\text{TO}}^2 = \omega_{A_1(\text{TO})}^2 \cos^2 \theta + \omega_{E_1(\text{TO})}^2 \sin^2 \theta. \quad (25)$$

Instead in a strongly anisotropic material, $A_1(\text{TO})$ and $A_1(\text{LO})$ [or $E_1(\text{TO})$ and $E_1(\text{LO})$] mix. Since we are interested in crystals with a small anisotropy, the Raman polarizabilities a and b will be taken as equal to simplify the final expressions, i.e.,

$$\mathcal{R}(A_1) \approx \begin{pmatrix} a & 0 & 0 \\ 0 & a & 0 \\ 0 & 0 & a \end{pmatrix}. \quad (26)$$

With this approximation, we can easily obtain the Raman selection rules in backscattering from the lateral side of a single WZ-NW grown along the c -axis. Looking at the picture given by Sander et al.,⁶¹ the x axis is perpendicular to the m -plane ($10\bar{1}0$) [(100) plane in three-index notation], while the y axis corresponds to the a -plane ($11\bar{2}0$) [(110) in three-index notation]. The z axis is along c , the $[0001]$ direction ([111] direction of the ZB).

The selection rules for a few standard configurations are summarized in Table 1. If one is interested in polar plots, we have to calculate the components of the Raman tensor. Let us do, as an example, the scattering configuration $x(\zeta(\phi)\zeta(\phi))\bar{x}$ where ζ is in the zy plane. The vectors $e_L' = (0, 0, 1)$ and $e_S' = (0, -\sin \phi, \cos \phi)$.

The Raman intensities will be, in the $x(\zeta\zeta)\bar{x}$ configuration,

$$|a_{\text{TO}}|^2 \cos^2 \phi + |c_{\text{TO}}|^2 \sin^2 \phi. \quad (27)$$

We have summed the squares (without considering any interference) since they are different phonon modes or different final states. However, we have to remember that they mix, and give an intermediate frequency between the $A_1(\text{LO})$ and $E_1(\text{LO})$ or the $A_1(\text{TO})$ and the $E_1(\text{TO})$, in agreement with Eq. (25).

Table 1 Selection rules for backscattering configuration from the a plane (nanowire lying in a surface) and c plane (nanowire perpendicular to the surface or a bunch of nanowires).

Scattering configuration	Raman component
$x(yy)\bar{x}$	$ a_{TO} ^2, d ^2$
$x(zz)\bar{x}$	$ a_{TO} ^2$
$x(yz)\bar{x}$	$ c_{TO} ^2$
$z(xx)\bar{z}$	$ a_{LO} ^2, d ^2$
$z(yy)\bar{z}$	$ a_{LO} ^2, d ^2$
$z(xy)\bar{z}$	$ d ^2$

5 Theory of Polariton Modes in a Crystal

The number of phonon modes in a crystal depends on the number of atoms in the unit cell. As is well known from a general course of solid-state physics, if a unit cell (primitive cell) has n atoms, there are $3n - 3$ optical modes. Depending on the complexity of the crystal, we can have from a few to tens of optical modes. For instance, in silicon, there are three optical modes, as in ZB-type materials; in WZ materials, there are nine optical modes (seven are Raman active), while in a more complex material, like Bi_2S_3 and isostructural layered materials, there are 57 optical phonons, 27 of them Raman active.⁶² In the case of an NW, there is no translational symmetry in the plane perpendicular to the NW axis. If the NW is very thin (a few nanometers of radius), we have confined modes (see Sec. 7). With increasing NW radius increases, the confined phonon modes overlap due to the finite linewidth, giving rise to an asymmetry at the low frequency region of the LO or TO phonon peaks. NWs of the order of several tens of nanometers can be considered, for most of the purposes, as a bulk material. Just as an example, in transport phonons can be treated as bulk materials even for NW diameters down to 30 to 40 nm.⁶³ The only difference will come from the existence of a surface or an interface (core/shell NWs), giving rise to new phonon modes, the so-called surface optical (SO) modes.

Let us start our discussion analyzing bulk phonons (i.e., there is no surface) in a solid. From group theory (at $q = 0$), there is no splitting of the optical modes; LO and TO modes have the same energy. Actually, the LO – TO splitting is produced at finite q in polar semiconductors due to the coupling of the phonon field with the electromagnetic field of the light (phonon–polariton). In bulk materials, the polariton branches are derived from the solution of the Maxwell equations inside the material and the coupling of electric field produced by the phonon displacement with the electric field of the electromagnetic wave.⁶⁴ From the LO to the TO frequencies, there is a forbidden region where the electromagnetic wave cannot propagate in bulk materials (the electromagnetic field is totally reflected). Actually, because of the losses (imaginary part of the dielectric function), the reflectivity is not exactly one in this region.

Although the coupling between the ionic displacement in a polar crystal and the electric field of the electromagnetic wave of the light is produced directly in the infrared region of the spectrum, it can be analyzed by Brillouin scattering,⁶⁵ and this coupling is responsible for the existence of surface modes, as we will see later. In a Raman experiment in backscattering geometry, $q \approx 4\pi n_L / \lambda_L$, where n_L and λ_L are the refractive index and wavelength of the laser light, respectively. For the typical green line of an Ar laser ($\lambda_L = 514.5308$ nm), $q \approx 0.08$ nm⁻¹. In a Brillouin scattering experiment, the complete measurement range is below this amount.

If we consider the harmonic movement corresponding to a phonon traveling along the crystal, the equation of motion will be that corresponding to the harmonic oscillator. On the other hand, if there is an electromagnetic wave in the polar crystal, there is a polarization vector proportional to the electric field, the proportionality constant being the electric susceptibility at a microscopic scale. But these fields are coupled through the ionic movement. Let $\mathbf{u} = \mathbf{u}_+ - \mathbf{u}_-$ be the vector displacement between the positive and negative ion in a simple polar semiconductor (as the ZB, for instance) and $\mathbf{w} = \sqrt{\mu/v_c} \mathbf{u}$, (μ/v_c is basically the density ρ_M , the mass density).

The equations to be solved in order to obtain both the electric polarization and the vector displacement due to the existence of the external field $\mathbf{E}$ are

$$\frac{\partial^2 \mathbf{w}}{\partial t^2} = -\omega^2 \mathbf{w} = b_{11} \mathbf{w} + b_{12} \mathbf{E} \quad \mathbf{P} = b_{21} \mathbf{w} + b_{22} \mathbf{E}. \quad (28)$$

Equation (28) must fulfill at the same time the Maxwell equations, which we write in the Gaussian system, for simplicity, and assume a plane wave solution $e^{i(\mathbf{k} \cdot \mathbf{r} - \omega t)}$,

$$\begin{aligned} \nabla \cdot (\mathbf{E} + 4\pi \mathbf{P}) &= 0 \Rightarrow \mathbf{k} \cdot (\mathbf{E} + 4\pi \mathbf{P}) = 0 & \nabla \cdot \mathbf{H} &= 0 \Rightarrow \mathbf{k} \cdot \mathbf{H} = 0 \\ \nabla \times \mathbf{E} &= -\frac{1}{c} \frac{\partial \mathbf{H}}{\partial t} \Rightarrow \mathbf{k} \times \mathbf{E} = \frac{\omega}{c} \mathbf{H} & \nabla \times \mathbf{H} &= \frac{1}{c} \left(\frac{\partial \mathbf{E}}{\partial t} + 4\pi \frac{\partial \mathbf{P}}{\partial t} \right) \Rightarrow -\mathbf{k} \times \mathbf{H} = \frac{\omega}{c} (\mathbf{E} + 4\pi \mathbf{P}). \end{aligned} \quad (29)$$

Combining these equations, we arrive to the solution

$$\mathbf{E} = 4\pi \frac{(\omega^2/c^2) \mathbf{P} - (\mathbf{k} \cdot \mathbf{P}) \mathbf{k}}{k^2 - \omega^2/c^2}. \quad (30)$$

At very high frequencies, the ionic movement cannot follow the electric field, only the electrons, and we arrive to the trivial solution

$$\mathbf{P} = b_{22} \mathbf{E} = \frac{\varepsilon_\infty - 1}{4\pi} \mathbf{E}. \quad (31)$$

On the other hand, uncoupled transverse phonons do not carry electric field and thus vibrate at their resonant frequency ω_{TO} , thus $b_{11} = -\omega_{\text{TO}}^2$. Finally, in static conditions ($\partial^2 \mathbf{w} / \partial t^2 = 0$), we obtain from the coupled Eq. (28)

$$\mathbf{P} = \left[\frac{b_{12} b_{21}}{-\omega_{\text{TO}}^2} + \frac{\varepsilon_\infty - 1}{4\pi} \right] \mathbf{E} = \frac{\varepsilon_0 - 1}{4\pi} \mathbf{E}. \quad (32)$$

The final expressions coupling the fields and atomic movement are

$$(\omega_{\text{TO}}^2 - \omega^2) \mathbf{w} = \sqrt{\frac{(\varepsilon_0 - \varepsilon_\infty)}{4\pi}} \omega_{\text{TO}}^2 \mathbf{E}, \quad (33)$$

$$\mathbf{P} = \sqrt{\frac{(\varepsilon_0 - \varepsilon_\infty)}{4\pi}} \omega_{\text{TO}}^2 \mathbf{w} + \frac{\varepsilon_\infty - 1}{4\pi} \mathbf{E}. \quad (34)$$

Taking the displacement from Eq. (33), substituting in Eq. (34), and using Eq. (30) in the particular case of transverse modes ($\mathbf{P} \cdot \mathbf{k} = 0$), we arrive at the following equation:

$$\frac{k^2 c^2}{\omega^2} = \frac{\varepsilon_0 \omega_{\text{TO}}^2 - \varepsilon_\infty \omega^2}{\omega_{\text{TO}}^2 - \omega^2}. \quad (35)$$

Using Eq. (35), we arrive at the solution

$$\omega^2 = \frac{1}{2\varepsilon_\infty} (\omega_{\text{TO}}^2 \varepsilon_0 + c^2 k^2) \left[1 \pm \sqrt{1 - \frac{4\varepsilon_\infty \omega_{\text{TO}}^2 c^2 k^2}{(\omega_{\text{TO}}^2 \varepsilon_0 + c^2 k^2)^2}} \right]. \quad (36)$$

The solution of Eq. (36) is given in Fig. 6 using the data of GaAs.⁴² At $k = 0$, there are two solutions obtained from the last equation taking the limit $k \rightarrow 0$: $\omega = \omega_{\text{LO}}$ and $\omega = (c/\sqrt{\varepsilon_0})k$. For large values of k , we obtain, taking the limit $k \rightarrow \infty$, $\omega = \omega_{\text{TO}}$ and $\omega = (c/\sqrt{\varepsilon_\infty})k$. The

Fig. 6 Lower and upper polariton branch in bulk GaAs calculated from Eq. (36) using the data of GaAs.⁴²

longitudinal solutions are obtained assuming $\mathbf{P} \cdot \mathbf{k} = Pk \Rightarrow E = -4\pi P \Rightarrow D = 0$. From the coupled equations, $\omega = \omega_{LO}$. In Sec. 6.1, we will see how these equations are modified due to the existence of a limiting surface in the solid. The value of the electric field can be recovered from Eq. (28). In the case of TO modes, Eq. (28) gives $E = 0$, and for LO modes,

$$\mathbf{E} = -\sqrt{4\pi\omega_{TO}^2 \left(\frac{1}{\epsilon_{\infty}} - \frac{1}{\epsilon_0} \right)} \mathbf{w}. \quad (37)$$

We can follow the same strategy to analyze the polariton dispersion in a crystal with the WZ structure. There are two modes, which are Raman and infrared active, A_1 (a 1-D mode vibrating along the c axis of the WZ structure) and E_1 (a 2-D mode vibrating in the plane perpendicular to the c axis). In a uniaxial crystal, the dielectric function is a tensor, isotropic in the plane perpendicular to c . Let us write

$$\epsilon = \begin{pmatrix} \epsilon_{\perp} & 0 & 0 \\ 0 & \epsilon_{\perp} & 0 \\ 0 & 0 & \epsilon_{\parallel} \end{pmatrix}. \quad (38)$$

We will restrict ourselves to the case where the phonons propagate along the z axis and the x axis ($\mathbf{k}$ is along z or x —the y direction is equivalent to x). If $\mathbf{k} \parallel \hat{z}$, we have a A_1 (LO) mode and two degenerate E_1 (TO) modes (vibration along x and y). If the phonons propagate along the x (or y) direction, we will have the A_1 (TO) mode vibrating along z and propagating along x and two E_1 modes, a mode vibrating along x and propagating along x , the E_1 (LO), and a second mode vibrating along y and propagating along x , the E_1 (TO). Obviously, these two modes are not degenerate in that case.

For the case where $\mathbf{k} \parallel \hat{z}$, the electric field can be along the x axis (or y). In that case, Eq. (30) becomes

$$E_x = 4\pi \frac{\omega^2 P_x}{k^2 c^2 - \omega^2}. \quad (39)$$

The equations coupling the fields with the atomic movement are

$$(\omega_{\parallel}^2 - \omega^2)w_x = \sqrt{\frac{(\epsilon_0^{\parallel} - \epsilon_{\infty}^{\parallel})}{4\pi}} \omega_{\parallel}^2 E_x \quad P_x = \sqrt{\frac{(\epsilon_0^{\parallel} - \epsilon_{\infty}^{\parallel})}{4\pi}} \omega_{\parallel}^2 w_x + \frac{\epsilon_{\infty}^{\parallel} - 1}{4\pi} E_x. \quad (40)$$

The same solution is obtained if the fields and ions vibrate in the y plane [exchanging x by y in Eqs. (39) and (40)]. The solutions are the dispersion of the two E_1 (TO) degenerate modes. By solving the three equations, we arrive at a solution equivalent to that of Eq. (36), replacing ω_{TO} by $\omega_{\parallel}$ and ϵ by $\epsilon^{\parallel}$. The solution can be better written in an equivalent way as Eq. (30).

$$\frac{k^2 c^2}{\omega^2} = \frac{\epsilon_0^{\parallel} \omega_{\parallel}^2 - \epsilon_{\infty}^{\parallel} \omega^2}{\omega_{\parallel}^2 - \omega^2}. \quad (41)$$

The limits $k \rightarrow 0$ and $k \rightarrow \infty$ are easily extracted from these equations, $\omega = (c/\sqrt{\epsilon_0^{\parallel}})k$ and $\omega = (c/\sqrt{\epsilon_{\infty}^{\parallel}})k$, respectively (see Fig. 7).

Here the electric field and the movement is along z ; the solution is $E_z = -4\pi P_z$ ($D = 0$), corresponding to the A_1 (LO) with frequency $\omega = \sqrt{\epsilon_0^{\parallel}/\epsilon_{\infty}^{\parallel}} \omega_{\parallel}$. These solutions are plotted in Fig. 7 for ZnO. If k is along the x axis, the E_1 mode propagating along the x direction will be longitudinal, with frequency $\omega = \sqrt{\epsilon_0^{\perp}/\epsilon_{\infty}^{\perp}} \omega_{\perp}$. The dispersion of the modes propagating along y and z are obtained by solving the equations

$$\frac{k^2 c^2}{\omega^2} = \frac{\epsilon_0^{\perp} \omega_{\perp}^2 - \epsilon_0 \omega^2}{\omega_{\perp}^2 - \omega^2}, \quad (42)$$

$$\frac{k^2 c^2}{\omega^2} = \frac{\epsilon_0^{\parallel} \omega_{\parallel}^2 - \epsilon_0 \omega^2}{\omega_{\parallel}^2 - \omega^2}, \quad (43)$$

respectively. The dispersion is shown in Fig. 7.

In the figures with the polariton branches, k has been written in wave numbers.

In the case of Raman scattering, the value of q is far away from the polariton region. In backscattering configuration and assuming that the selection rules are fulfilled (that depends on the cylinder radius), $q = k_L - k_S$. For $\lambda_L = 514.53$ nm, the laser frequency in cm^{-1} is $\omega_L = 1/\lambda_L = 19,435.213 \text{ cm}^{-1}$. The scattered frequency, for instance, for Si is $\omega_S = 19,435.213 - 519.5 = 19,383.263 \text{ cm}^{-1}$ (515.909 nm). The value of q will be $q = 2\pi n_L/\lambda_L + 2\pi n_S/\lambda_S \approx 4\pi n_L/\lambda_L \approx 0.0855 \text{ nm}^{-1} = 855,000 \text{ cm}^{-1}$ (in the polariton region, $k \leq 15,000 \text{ cm}^{-1}$).

Fig. 7 Lower and upper polariton branch in bulk ZnO calculated from Eq. (36) using the data of ZnO.⁶⁶

6 Surface Optical Modes

6.1 Surface Optical Modes Within the Polariton Description

In finite-size samples, there are additional conditions on the electric and the magnetic fields since they must fulfill the boundary conditions at the sample surface. The existence of these boundary conditions generates additional solutions in the polariton equations. In general, there is a complete set of solutions ranging from below the TO to above the LO region, depending on the geometry.

Let us consider a single cylindrical semiconductor NW of radius a , with a dielectric permittivity $\varepsilon(\omega)$, and an electromagnetic field with time dependence $e^{-i\omega t}$. If the external medium has a dielectric permittivity ε_M (in case of air or vacuum, $\varepsilon_M = 1$), the electric and magnetic fields outside and inside of the NW must fulfill the Helmholtz equations.

$$\left[\nabla^2 + \varepsilon(\omega) \frac{\omega^2}{c^2} \right] \mathbf{E} = 0; \quad \left[\nabla^2 + \varepsilon(\omega) \frac{\omega^2}{c^2} \right] \mathbf{H} = 0 \quad (44)$$

inside the material and

$$\left[\nabla^2 + \varepsilon_M \frac{\omega^2}{c^2} \right] \mathbf{E}_0 = 0; \quad \left[\nabla^2 + \varepsilon_M \frac{\omega^2}{c^2} \right] \mathbf{H}_0 = 0 \quad (45)$$

outside the material. The Helmholtz equation can be solved exactly in six coordinate systems,⁶⁷ in particular, in cylindrical coordinates. In case of a hexagonal cross-section, the main conclusions from this section will not vary, but the calculation of the electromagnetic field must be done numerically due to the complexity of the boundary conditions.

Let us call $k^2 = \varepsilon(\omega)\omega^2/c^2$ and $k_0^2 = \varepsilon_M\omega^2/c^2$. Equations (44), in cylindrical coordinates, become, for a scalar function ψ ,

$$\left[\frac{\partial^2}{\partial \rho^2} + \frac{1}{\rho} \frac{\partial}{\partial \rho} + \frac{1}{\rho^2} \frac{\partial^2}{\partial \theta^2} + \frac{\partial^2}{\partial z^2} + k^2 \right] \psi = 0 \quad (46)$$

inside the material. Outside, we have to replace k by k_0 . By assuming a solution of the type $R(\rho)e^{i\theta}e^{ik_z z}$, we arrive at the equation

$$x^2 \frac{d^2 R(x)}{dx^2} + \frac{dR}{dx} + (x^2 - n^2)R(x) = 0, \quad (47)$$

where $x^2 = \beta^2 \rho^2 \equiv (k^2 - k_z^2)\rho^2$ [or $x^2 = \beta_0^2 \rho^2 \equiv (k_0^2 - k_z^2)\rho^2$ outside the crystal] and whose solutions are Bessel functions of first class $[J_n(\beta\rho)]$, second class $[Y_n(\beta\rho)]$, also called Neumann functions, and third class $[H_n^{(1)}(\beta\rho)$ or $H_n^{(2)}(\beta\rho)]$, or Hankel functions. Inside the cylinder, the solution is of the type $J_n(\beta\rho)$ (analytical at the origin), and outside the cylinder, it is more convenient to take Hankel functions $[H_n^{(1)}(\beta_0\rho) = J_n(\beta\rho) + iY_n(\beta_0\rho)]$, i.e.,

$$\psi(\mathbf{r}) = e^{i\theta} e^{ik_z z} \times \begin{cases} AJ_n(\beta\rho) & \rho \leq a \\ BH_n(\beta\rho) & \rho \geq a \end{cases} \quad (48)$$

where we have removed the superindex of the Hankel function for clarity. The Hankel functions can be expanded in plane waves.⁶⁸

$$H_n(\rho)e^{i\phi} = \int_{-\infty}^{+\infty} F_n(\beta) e^{i\beta\rho \cos \phi} d\beta. \quad (49)$$

We are interested in the absorption (transmission, scattering) of a plane wave (laser beam) by a semiconducting cylinder.

It is also possible to assume a conducting hollow of radius ρ_0 , $\rho_0 \gg a$. In that case, the solution outside the cylinder will be Neumann functions. Once we have the solution for the Helmholtz scalar equation, those for the vector equations are easily obtainable. For instance, following Ref. 68, two vector solutions are

$$\mathbf{M} = \nabla \times \mathbf{u}_z \psi; \quad N = \frac{1}{\beta} \nabla \times \nabla \times \mathbf{u}_z \psi, \quad (50)$$

where ψ is the solution of the scalar equation. The modes cannot, in general, be split into transversal electric and magnetic; they are mixed through the boundary conditions (due to the existence of a surface). In the general case, the eigenfrequencies are obtained by solving the equation⁶⁰

$$\left[\frac{1}{\beta a} \frac{J'_n(\beta a)}{J_n(\beta a)} - \frac{1}{\beta_0 a} \frac{H'_n(\beta_0 a)}{H_n(\beta_0 a)} \right] \left[\frac{k^2}{\beta a} \frac{J'_n(\beta a)}{J_n(\beta a)} - \frac{k_0^2}{\beta_0 a} \frac{H'_n(\beta_0 a)}{H_n(\beta_0 a)} \right] = \left[\frac{nk_z}{R^2} \left(\frac{1}{\beta^2} - \frac{1}{\beta_0^2} \right) \right]^2. \quad (51)$$

However, the most interesting case corresponds to the analysis of a single NW when the light incides in the xy plane. In that case, $k_z = k_{0z} = 0$ and the scalar function does not depend on z . Let us suppose that the electromagnetic wave has the electric field component along z . Since the tangential component of E must be conserved, $E_z = E_{0z}$. From the Faraday equation, $\nabla \times E = i\omega \mathbf{H}$.

$$\frac{1}{\rho} \frac{\partial E_z}{\partial \theta} \mathbf{u}_\rho - \frac{\partial E_z}{\partial \rho} \mathbf{u}_\theta = i\omega \mathbf{H}. \quad (52)$$

Since we are considering a nonmagnetic medium, both the normal and tangential components of $\mathbf{H}$ will be continuous when crossing the surface. We arrive at the following three equations corresponding to the continuity of E_z , H_θ , and H_ρ :

$$AJ_n(ka) = BH_n(k_0a) \quad AJ_n(ka) = BH_n(k_0a) \quad AkJ'(ka) = Bk_0H'(ka), \quad (53)$$

where the first two equations are the same. By solving the equation for the coefficients A and B ,

$$\sqrt{\frac{\varepsilon(\omega)}{\varepsilon_M}} \frac{J'_n(ka)}{H'_n(k_0a)} = \frac{J_n(ka)}{H_n(k_0a)}. \quad (54)$$

The modes solution of this equation are called E -polarized. On the other hand, if the magnetic field has only a z component, we have to use the fourth Maxwell equation $\nabla \times \mathbf{H} = -i\omega \mathbf{D}$, where the displacement vector $\mathbf{D} = \varepsilon(\omega)\mathbf{E}$ inside the material and $\mathbf{D} = \varepsilon_M\mathbf{E}$ outside. From the continuity of the tangential component of $\mathbf{H}$, the normal component of $\mathbf{D}$, and the tangential of $\mathbf{E}$, we arrive at the equations

$$J_n(ka) = AH_n(k_0a) \quad J_n(ka) = AH_n(k_0a) \quad \frac{k}{\varepsilon(\omega)} J'(ka) = A \frac{k_0}{\varepsilon_M} H'(ka). \quad (55)$$

The transcendental equation for the H -polarized modes is

$$\frac{J'_n(ka)}{H'_n(k_0a)} = \sqrt{\frac{\varepsilon(\omega)}{\varepsilon_M}} \frac{J_n(ka)}{H_n(k_0a)}. \quad (56)$$

These equations give a set of eigenvalues below the TO frequency, in the gap between the TO and the LO, and above the LO. In the limit $a \rightarrow 0$, the solutions are very simple. In the case of E -polarized modes, for $n = 0$, there is only one solution, $\omega = \omega_{\text{TO}}$, the bulk solution. When a increases, a number of solutions appear below the TO region. For increasing a , there are solutions in the gap and above the LO region. But for thin NWs, there is only one solution, $\omega = \omega_{\text{TO}}$. In the case of H -polarized modes, there are no crossing points for $n = 0$. In other words, for $n = 0$, there is only one solution, which corresponds to the bulk mode in the E -polarized case. For $n = 1$, and $a \rightarrow 0$, the solution of Eq. (56) gives

$$\omega_{\text{SO}}^2 = \frac{\varepsilon_0 + \varepsilon_M}{\varepsilon_\infty + \varepsilon_M} \omega_{\text{TO}}^2 \quad (57)$$

corresponding to $\sqrt{\epsilon(\omega_{SO})/\epsilon_M} = i$. Actually, in the range between ω_{TO} and ω_{LO} , where the dielectric function is negative, the Bessel function $J_n(ix) = i^n I_n(x)$; it can be written in terms of the modified Bessel function. In Fig. 8, we have plot the dielectric permittivity for GaP [$\omega_{TO} = 367 \text{ cm}^{-1}$ and $\omega_{LO} = 403 \text{ cm}^{-1}$, and $\epsilon_\infty = 9.075$ (Ref. 69)] as a function of ω . As must be expected, the dielectric function diverges at $\omega = \omega_{TO}$ and becomes negative for $\omega > \omega_{TO}$ until $\omega = \omega_{LO}$, where it becomes zero. Two dashed lines indicate the limits ϵ_∞ and ϵ_0 (calculated from the Lyddane–Sachs–Teller relations with the data supplied in Ref. 69). In the inset, we show the region close to ω_{LO} , where we can observe the surface optical modes. The horizontal lines correspond to $\epsilon(\omega_{SO}) = -1, -2$ and -3 , obtained from the transcendental Eq. (56) taking $\epsilon_M = 1, 2, 3$. The vertical lines are the different frequencies, which can be calculated accurately with Eq. (56). We can observe how the frequency of the surface mode shifts down depending on the external or surrounding medium. From air to a surrounding medium with $\epsilon_M = 3$, there is a shift of $>5 \text{ cm}^{-1}$.

We will compare this result with that given in Sec. 6.2, neglecting retardation. We have to keep in mind that the first surface optical mode is obtained when the electric field is perpendicular to the NW direction, and it corresponds to the $n = 1$ solution of Eq. (56). In the case $n = 0$, there is no crossing point. In the case of E -polarized modes ($n = 0$), we obtain the bulk solution ($\omega = \omega_{TO}$) in small diameter NWs.

6.2 Surface Modes Within the Nonretarded Limit

The advantage of writing the Maxwell equations in the Gaussian system is that the nonretarded limit is obtained simply with the limit $c \rightarrow \infty$. In other words, the magnetic field contribution is neglected. Since $\nabla \times \mathbf{E} = 0$, we can write $\mathbf{E} = -\nabla V$. On the other hand, we have $\nabla \cdot \mathbf{D} = 0$. Inside the material, $\mathbf{D} = \epsilon(\omega)\mathbf{E}$, while outside the material $\mathbf{D} = \epsilon_M\mathbf{E}$. In both cases, we can write $\nabla \cdot \mathbf{E} = \nabla^2 V = 0$, and we arrive at the Laplace equation instead of the Helmholtz equation for the surface modes.⁶⁰

$$\nabla^2 V(\rho, \phi, z) = \left[\frac{1}{\rho} \frac{\partial}{\partial \rho} \left(\rho \frac{\partial}{\partial \rho} \right) + \frac{1}{\rho^2} \frac{\partial^2}{\partial \phi^2} + \frac{\partial^2}{\partial z^2} \right] V(\rho, \phi, z) = 0, \quad (58)$$

Fig. 8 Real part of the dielectric permittivity, as a function of ω in the region of interest between the TO and LO. At the TO frequency, there is a divergence, and at ω_{LO} , the dielectric function is zero. Three optical surface frequencies corresponding to external media with $\epsilon_M = 1$ (air), $\epsilon_M = 2$, and $\epsilon_M = 3$ with the data of GaP.⁶⁹

where $V(\rho, \phi, z)$ is the electrostatic potential. Actually, we are also assuming that $\nabla \cdot \mathbf{P} = 0$, i.e., there are no volume polarization charges. In cylindrical coordinates, this equation can be solved by separation of variables, considering

$$V(\rho, \phi, z) = R(\rho)\Phi(\phi)e^{iq_z z}, \quad (59)$$

where z is the axis of the cylinder and q_z the phonon wave vector along the z direction. Substituting into Eq. (58) and multiplying by ρ^2 ,

$$\frac{\rho}{R} \frac{\partial}{\partial \rho} \left(\rho \frac{\partial R}{\partial \rho} \right) - \rho^2 q_z^2 = -\frac{1}{\Phi} \frac{\partial^2 \Phi}{\partial \phi^2} = n^2 \quad (60)$$

by choosing $\Phi = e^{in\phi}$. Rewriting the equation in terms of $x = q_z \rho$,

$$x^2 \frac{\partial^2 R}{\partial x^2} + x \frac{\partial R}{\partial x} - (x^2 + n^2)R = 0, \quad (61)$$

whose solutions are the modified Bessel functions $I_n(x)$ and $K_n(x)$. Since $I_n(q_z \rho) \rightarrow \infty$ when $\rho \rightarrow \infty$ and $K_n(q_z \rho) \rightarrow \infty$ when $\rho \rightarrow 0$, the potential has the solution

$$V(\rho, \phi, z) = e^{in\phi} e^{iq_z z} \times \begin{cases} AI_n(q_z \rho) & \rho \leq a \\ BK_n(q_z \rho) & \rho \geq a \end{cases}, \quad (62)$$

where A and B are constants indicating the strengths of the fields. Once we know the potential, we can calculate the electric field, which in cylindrical coordinates is

$$\mathbf{E} = -\frac{\partial V}{\partial \rho} \hat{\rho} - \frac{1}{\rho} \frac{\partial V}{\partial \theta} \hat{\theta} - \frac{\partial V}{\partial z} \hat{z}. \quad (63)$$

At the surface of the cylinder ($\rho = a$), the boundary conditions for the fields (D_ρ , E_ϕ , and E_z) must be fulfilled. This requirement gives rise to the following two equations:

$$\begin{aligned} A\varepsilon(\omega)q_z I_n'(q_z a) &= B\varepsilon_M q_z K_n'(q_z a) & A \frac{\text{in}}{a} I_n(q_z a) &= B \frac{\text{in}}{a} K_n(q_z a) \\ A \frac{iq_z}{a} I_n(q_z a) &= B \frac{iq_z}{a} K_n(q_z a). \end{aligned} \quad (64)$$

The last two equations are identical. Solving the first two equations for A and B ,

$$\frac{\varepsilon(\omega)}{\varepsilon_M} = \frac{K_n'(q_z a) I_n(q_z a)}{K_n(q_z a) I_n'(q_z a)} \equiv f_{nq_z}. \quad (65)$$

Appealing to the expression for the dielectric function

$$\varepsilon(\omega) = \varepsilon_\infty + \frac{\varepsilon_0 - \varepsilon_\infty}{1 - \omega^2/\omega_{\text{TO}}^2 - i\gamma\omega/\omega_{\text{TO}}} \quad (66)$$

and using Eq. (65), the following useful expression can be derived:

$$\frac{\omega_{nq_z}^2}{\omega_{\text{TO}}^2} = \frac{\varepsilon_0 - f_{nq} \varepsilon_M}{\varepsilon_\infty - f_{nq} \varepsilon_M}, \quad (67)$$

where $n = 0, 1, \dots$ correspond to the different surface modes. This expression has been written in the literature in several ways, most commonly in terms of the plasma frequency. It should be pointed out that one of the most common references on surface modes has an error; in Eq. (7.41) of Sernelius's book,⁷⁰ the case $n = 0$ may correspond to $\varepsilon(\omega) \rightarrow \infty$ and not to 0 since the dielectric function diverges at $\omega = \omega_{\text{TO}}$. On the other hand, since we have also found a mistake in a

Fig. 9 (a) The solid line corresponds to the $n = 0$ mode, converging to ω_{TO} at $a \rightarrow 0$ (E_0). (b) Detail of the dispersion of the first SO mode ($n = 1$) using the experimental data of InAs.¹⁵ The calculation of q_z is explained in the text. The corresponding energy for $q_z a \approx 0.02$ to 0.03 gives a small energy shift toward lower energy, although negligible.

commonly used mathematical table,⁷¹ we write down here the expressions of the derivatives of I_n and K_n , which are actually different.

$$I'_n(x) = \frac{1}{2}(I_{n-1} + I_{n+1}); \quad K'_n(x) = -\frac{1}{2}(K_{n-1} + K_{n+1}). \quad (68)$$

The correct expressions can be checked, for instance, in the book of Arfken et al.⁶⁷ Taking the limit $a \rightarrow 0$, we obtain

$$\omega_{SO}^2 = \frac{\epsilon_0 + \epsilon_M}{\epsilon_\infty + \epsilon_M} \omega_{TO}^2. \quad (69)$$

the expression found in many text books.⁷² Actually, if $q_z \rightarrow 0$ (there is no propagation in the z direction), we have the same result, which was previously found in the retarded limit. The solution corresponding to $n = 0$ is the bulk solution ($E \parallel \hat{z}$, corresponding to $\omega = \omega_{TO}$), while that corresponding to $n = 1$ is the H -polarized mode.^{60,73} In Fig. 9, we can see in the left panel (a) the three first solutions of Eq. (67). For a fixed q_z , as soon as a increases, we move from the bulk solution ($\omega = \omega_{TO}$) of the cylinder to the solution of the slab (when the radius of the cylinder $a \rightarrow \infty$), and there is no difference between $E \parallel \hat{z}$ and E parallel to the other in plane coordinate. For small radius ($a \rightarrow 0$), the first surface mode corresponds to $n = 1$ and it is H -polarized; the electric field component will be along E_ϕ . In Fig. 9, right panel, we have drawn the first surface phonon solution, for $\epsilon_M = 1$, a material surrounded by air. Assuming, as an example, $\lambda_L = 514.38$ nm and $q = 0.0855$ nm⁻¹ (see end of Sec. 6), a NW of $a = 100$ nm, and a numerical aperture of $NA = 0.9$, following the deduction at the end of the Introduction, $q_z a \approx 0.02$ to 0.03 . Looking at Fig. 9 (right panel), the SO mode will be nearly at the same value as that calculated by the usual expression. Actually, this calculation corresponds to the maximum value of q_z ; thus the SO mode must be in between the value corresponding to $q_z = 0$ and the maximum q_z . In summary, we can neglect any deviation from Eq. (57). Obviously, q_z is conserved in an infinite cylinder and the Raman selection rules must be fulfilled.

7 Raman Scattering by Confined Optical Modes

The dielectric continuum approximation and the dispersive hydrodynamic model have been used in the past to describe the optical confined modes in several kinds of heterostructures.^{74,75} They predict different symmetry patterns for the electrostatic potential and the phonon displacement. In an isotropic continuum model, the LO and TO phonons are decoupled in bulk materials, while, as we have seen in Sec. 6, they couple in the general case due to the existence of a surface that mixes them, and new modes related to the surface (surface optic modes) appear. The existence of SO modes can also be related to the cut-off in the Coulomb sum since the crystal is not

infinite. We have already written the basic equations needed for the study of the confined modes in a cylindrical quantum wire; they are given by Eqs. (33) and (34). The behavior of these modes (if decoupled) moving along the cylinder axis z is basically that of bulk modes due to the existence of translational symmetry. The phonons produce a deformation, which can be accounted for by including the stress tensor in the basic polariton equations. In Sec. 6 we have neglected this contribution. Actually, we have to modify Eq. (33) slightly to include the existence of local strain. In Ref. 74, we started with the Lagrangian formalism, but, basically, we have to modify Eq. (33) to the final form.

$$(\omega_{\text{TO}}^2 - \omega^2)\mathbf{u} = \sqrt{\frac{\varepsilon_0 - \varepsilon_\infty}{4\pi}} \rho_M \omega_{\text{TO}}^2 \mathbf{E} - \nabla \cdot \boldsymbol{\sigma}, \quad (70)$$

where we have assumed an $e^{-i\omega t}$ dependence and introduced ρ_M , the mass density, in order to keep the definition of the mechanical stress tensor $\boldsymbol{\sigma}$.

$$\sigma_{ij} = \frac{1}{2} \sum_{kl} \lambda_{ijkl} \left(\frac{\partial u_l}{\partial x_k} + \frac{\partial u_k}{\partial x_l} \right). \quad (71)$$

Equation (34) can be rewritten as

$$\mathbf{D} = \mathbf{E} + 4\pi\mathbf{P} = \sqrt{4\pi(\varepsilon_0 - \varepsilon_\infty)\rho_M\omega_{\text{TO}}^2} \mathbf{u} - \varepsilon_\infty \nabla V. \quad (72)$$

Using the first Maxwell equation,

$$\nabla^2 V = \sqrt{4\pi\rho_M\omega_{\text{TO}}^2} \left(\frac{\varepsilon_0 - \varepsilon_\infty}{\varepsilon_\infty} \right) \nabla \cdot \mathbf{u}. \quad (73)$$

The physical boundary conditions at the interface of the cylinder with the external medium (with dielectric constant ε_M) must be

- continuity of the electrostatic potential at $\rho = a$, a being the radius of the cylinder.
- continuity of the displacement vector $\mathbf{u}$ at the interface of the cylinder with the external surface [$\mathbf{u}_A = \mathbf{u}_B$ in a core/shell NW and $\mathbf{u} = 0$ in a free-standing wire (FSW)].
- continuity of the normal component of the displacement ($\mathbf{D} \cdot \hat{\boldsymbol{\rho}}$) at the interface.
- continuity of the stress component along the interface ($\boldsymbol{\sigma} \cdot \hat{\boldsymbol{\rho}} = 0$ in a FSW).

On the other hand, we consider the dispersion of the LO and TO modes in the xy plane in the simple way $\omega^2 = \omega_{\text{TO}}^2 - \beta_{\text{TO}}^2 Q^2$ and $\omega^2 = \omega_{\text{LO}}^2 - \beta_{\text{LO}}^2 q^2$, where the LO and TO modes are related through the Lyddane–Sachs–Teller relations, $\omega_{\text{LO}}^2 = (\varepsilon_0/\varepsilon_\infty)\omega_{\text{TO}}^2$. The parameters β_{TO} and β_{LO} indicate the curvature of the phonon branches, and the wavenumber has been labeled Q or q to distinguish between the phonon branches. We will see later that they are related to the sound velocity.

In order to simplify the description, we assume an isotropic elastic medium, with two elastic constants (Lamé coefficients λ and μ). In terms of the conventional elastic compliances,

$$\lambda = c_{12}; \quad \mu = c_{44} \approx \frac{1}{2}(c_{11} - c_{12}). \quad (74)$$

On the other hand, the transverse and longitudinal sound velocities in a solid are

$$c_T^2 = \frac{c_{44}}{\rho_M}; \quad c_L^2 = \frac{c_{11}}{\rho_M}. \quad (75)$$

In terms of the sound velocities,

$$\mu = \rho_M c_T^2; \quad \lambda = \rho_M (c_L^2 - 2c_T^2). \quad (76)$$

Introducing the Lamé coefficients into the stress tensor and replacing the sound velocities c_L and c_T by the coefficients β_L and β_T , Eq. (70) can be written as

$$(\omega^2 - \omega_{\text{TO}}^2)\mathbf{u} = \sqrt{\frac{\epsilon_0 - \epsilon_\infty}{4\pi\rho_M}}\omega_{\text{TO}}^2\nabla V + \beta_L^2\nabla(\nabla \cdot \mathbf{u}) - \beta_T^2\nabla \times \nabla \times \mathbf{u}, \quad (77)$$

where we have made use of the identity $\nabla \times \nabla \times \mathbf{u} = \nabla(\nabla \cdot \mathbf{u}) - \nabla^2 \mathbf{u}$. The solution of this complicated equation was solved by assuming⁷⁴

$$\mathbf{u} = \nabla\psi + \nabla \times \mathbf{A}, \quad (78)$$

where the additional condition $\nabla \cdot \mathbf{A} = 0$ was imposed.⁷⁵ After a little algebra, we arrive at the following set of four coupled partial derivative equations in cylindrical coordinates:

$$\nabla^2 \left[\nabla^2 \mathbf{A} + \frac{\omega_{\text{TO}}^2 - \omega^2}{\beta_{\text{TO}}^2} \mathbf{A} \right] = 0 \quad \nabla^2 \left[\nabla^2 \psi + \frac{\omega_{\text{LO}}^2 - \omega^2}{\beta_{\text{LO}}^2} \psi \right] = 0. \quad (79)$$

Assuming $q_z = 0$ [we are interested in the confined modes within the NWs (there is no confinement along z)], $u_z = 0$, and we can assume $\mathbf{A} = A_z(\rho, \theta)\hat{z}$ [and $\psi = \psi(\rho, \theta)$]. The displacement can be written as

$$u_\rho = \frac{\partial\psi}{\partial\rho} + \frac{1}{\rho} \frac{\partial A_z}{\partial\theta}; \quad u_\theta = \frac{1}{\rho} \frac{\partial\psi}{\partial\theta} - \frac{\partial A_z}{\partial\rho}. \quad (80)$$

The four coupled systems of equations reduce to two coupled equations, with solutions

$$\frac{1}{\rho} \frac{\partial}{\partial\rho} \left(\rho \frac{\partial A_z}{\partial\rho} \right) + \frac{1}{\rho^2} \frac{\partial^2 A_z}{\partial\theta^2} + \frac{\omega_{\text{TO}}^2 - \omega^2}{\beta_{\text{TO}}^2} A_z = f_1 \quad \frac{1}{\rho} \frac{\partial}{\partial\rho} \left(\rho \frac{\partial\psi}{\partial\rho} \right) + \frac{1}{\rho^2} \frac{\partial^2 \psi}{\partial\theta^2} + \frac{\omega_{\text{LO}}^2 - \omega^2}{\beta_{\text{LO}}^2} \psi = f_2, \quad (81)$$

where both functions f_1 and f_2 are solutions of the Laplace equation. The phonon displacements and the electrostatic potential are coupled through the two solutions.

The general solution of these equations have been already given in Ref. 75; here, we give only the secular equation.

$$2n(n-1) \left(\frac{\beta_{\text{LO}}}{\beta_{\text{TO}}} \right)^2 R^2 t_n(x, y) f_{n+2}(y) + 2ny^2 f_{n+2}(y) [x f'_n(x) - f_n(x)] \\ + g_n(x) [2y f'_n(y) + (y^2 - 2n^2) f_n(y)] = 0, \quad (82)$$

where the arguments are

$$x^2 = \frac{\omega_{\text{LO}}^2 - \omega^2}{\beta_{\text{LO}}^2} a^2; \quad y^2 = \frac{\omega^2 - \omega_{\text{TO}}^2}{\beta_{\text{TO}}^2} a^2. \quad (83)$$

The variable R is given by

$$R^2 = \frac{\omega_{\text{LO}}^2 - \omega_{\text{TO}}^2}{\beta_{\text{LO}}^2} a^2 \quad (84)$$

and the functions

$$g_n(x) = \left(\frac{\beta_{\text{LO}}}{\beta_{\text{TO}}} \right)^2 x^2 f_n(x) - 2(n+1) x f_{n+1}(x) \quad (85)$$

and

$$t(x, y) = \frac{\epsilon_\infty g_n(x) f_n(y) + \epsilon_M y^2 f_n(y) f_{n+2}(y)}{[\epsilon_\infty (\beta_{\text{LO}}/\beta_{\text{TO}})^2 x^2 + \epsilon_M y^2] f_{n+2}(y)}. \quad (86)$$

By solving these equations, we are able to find the complete set of eigenvalues for the different values of ω . The eigenvectors are obtained by introducing the corresponding eigenvalues into the expressions of the displacement and electrostatic potential.⁷⁵ In previous works,^{74,75} we have analyzed the case of an FSW, surrounded by air, and what we called a quantum wire, embedded

in a different semiconductor, in that particular case, GaAlAs. In that case, there are two surface and two boundary conditions. In the interface between the two semiconductors, the boundary conditions are the same as that previously discussed; in particular, the normal component of the stress tensor is continuous at the interface. In the external surface, the normal component of the stress is zero. There are two kinds of modes: interface modes located at the interface between the two semiconductors and a surface mode located at the external surface of the NW. Li has analyzed this last case of a core/shell NW for a GaAs/AlGaAs NW.⁷⁶ The difficulty arises because in the region of the shell, both the Bessel and Neumann functions are valid and the boundary conditions become a little bit cumbersome. In the work of Li,⁷⁶ he uses the first and second kind Bessel functions. In this last paper, Li limits the study to the interface and surface mode.

Figure 10 shows the confined phonon modes as a function of the cylinder radius. In the upper panel, the case where a GaAs NW is embedded in AlGaAs is shown for the case $n = 0$, $n = 1$, and $n = 2$. For $n = 0$, for instance, for $r_0 = 10$ Å, there are only two confined modes in the region between the LO and TO, but as soon as the radius increases, the number of modes increases rapidly. For $r_0 = 60$ Å, there are already 16 modes in that region. We observe two sets of curves, one converging to the bulk ω_{TO} and a second one converging to the bulk value of LO phonons ω_{LO} . Starting in $n = 1$, as we have commented in Sec. 6.2, the confined modes mix with the surface modes. In Ref. 74, this anticrossing can be observed more clearly since there are a few modes drawn and the decoupled modes have also been drawn. The calculation, for the GaAs/AlGaAs NW, corresponds to the expression

$$\omega_F^2 = \frac{\epsilon_{a0} + \epsilon_{b\infty}}{\epsilon_{a\infty} + \epsilon_{b\infty}} \omega_{\text{TO}}^2, \quad (87)$$

a and b being GaAs and AlGaAs (or vacuum in the case of an FSW). We called ω_F the frequency of the surface or interface mode because Fröhlich⁷⁷ did the calculation for the first time for the case of a dielectric sphere embedded in a second dielectric. The values obtained were $\hbar\omega_F = 34.15$ meV in the GaAs/AlGaAs NW and $\hbar\omega_F = 36.28$ meV for a GaAs NW.

It is interesting to realize, also, that in the case of $n = 0$, the surface modes do not appear, as commented in Sec. 6.2. The reason is that, for $n = 0$, the transcendent Eq. (82) decouples into two equations

$$2f'_0(y) + yf_0(y) = 0; \quad xf'_0(x) - f_0(x) = 0 \quad (88)$$

Fig. 10 Optical modes in cylindrical nanowires.

Fig. 11 Dispersion in a GaAs nanowire embedded into AlGaAs (Ref. 74) in the case $n = 1$. We have drawn the decoupled solutions, as explained in the text.

and the LO and TO phonons do not mix as in the case of an infinite material. For $n > 0$, there is a strong mixing of the LO and TO phonons, as can be observed, for instance, in the mode just below the bulk TO phonon limit in the case of the FSW. For $n > 0$, we clearly observe the surface optic phonon, which consists of a homogeneous polarization of the NW [$\epsilon(\omega) = -\epsilon_M$]. At this frequency [that given by Eq. (87)], there is no difference between longitudinal or transverse modes. Figure 11 shows the dispersion of a GaAs NW surrounded by AlGaAs when $n = 1$. We clearly see the surface mode, which appears at an intermediate frequency due to the large value of the external dielectric constant (constant in the region of GaAs phonons). We have also plotted the uncoupled solutions corresponding to bulk. We can see the surface mode, interface mode in that case, as a new solution due to the mixing of the LO and TO solutions, due to the existence of a surface or an interface.

In Ref. 75, the Fröhlich electron–phonon interaction Hamiltonian has been deduced for the case of confined phonons, both for free-standing NWs and NWs embedded in a different material (interface modes). Li⁷⁶ has calculated the interface and surface modes for a core/shell NW neglecting confinement effects. He has also obtained the Fröhlich electron–phonon Hamiltonian.

Since the number of confined modes increases drastically as soon as the NW radius increases, we basically have a continuity of modes since they cannot be spectroscopically separated. At 6 or 7 nm, we already have a continuity of modes, which can be observed in Raman as a broadened line. An example is the measurement reported by Zhang et al.⁷⁸ in Ge NWs. They group the NWs into a range of sizes and the Raman spectra are asymmetric, indicating either confinement or a smaller signal coming from the smaller NWs. In their Fig. 5, they show the Raman spectra of a set of NWs with diameters from 6 to 17 nm. Clearly, even with these diameters, wave vector is conserved, otherwise the one-phonon density of states would be visible. A theoretical study on nanoparticles, and also on 2-D and 1-D systems, was performed by Faraci et al.⁷⁹ The theoretical results show how a nanoparticle with a diameter of 10 nm has basically the same Raman spectrum as a 7-nm nanoparticle. In the case of 1.5- or 2-nm nanoparticles, the shape is asymmetric as commented in the case of Ge NWs. The width is compared for the case of three-dimensional (nanoparticles), 2-D, and 1D, which shows a smaller influence in the case of NWs (smaller shift) than in the case of nanoparticles.

8 Antenna Effect

In bulk materials, the light penetrates into the semiconductor depending on the absorption coefficient (or imaginary part of the dielectric function). The penetration depth in GaAs, close to the E_0 critical point, is ~ 100 nm. In general, even if the NW diameter is < 100 nm, a direct gap semiconductor strongly absorbs the light above the band gap (i.e., in resonant conditions).

Fig. 12 Electric field intensity maps around the cross-section of GaP nanowires calculated using the discrete dipole approximation.⁸² The two upper panels correspond to E-polarization (electric field along the wire), while the lower panels correspond to H-polarization (electric field perpendicular to the wire axis). The wire diameter of the two panels at the left is 200 nm, while that at the right is 50 nm.

However, the Raman intensity does not follow the classical selection rules in very thin NWs. There is a typical $\cos^2 \theta$ dipole dependence, and the maximum Raman signal is obtained when the polarization of the laser light is parallel to the NW axis. This behavior was observed for the first time in 2000 in single-wall carbon nanotubes,⁸⁰ and it was already predicted by Ajiki and Ando in 1994.⁸¹ Although there are several observations of this phenomenon, denominated antenna effect, in the literature in several semiconducting NWs, a couple of interesting works should be mentioned. The first one is a review of Xiong et al.,⁸⁰ where they summarize a set of experimental works done on GaP NWs ranging from 50 to 200 nm in diameter. They observe that the strong polarization disappears when the diameter d of the nanowire is $d \geq \lambda_L/4 \sim 120$ nm for the laser line used in the experiment (488 nm). The diameter is too large to be related to electron confinement effects. For NWs of 105 nm in diameter, they observe a $\cos^2 \theta$ behavior, while in a 160-nm wide NW, the emission has a multipolar character. In order to explain the observed behavior, they used the discrete-dipole approximation⁸⁰ to calculate the light absorption. In this approximation, the NW volume is replaced by a set of dipoles, which vibrate or interact with the incident electric field.

In Fig. 12, we reproduce the electric field maps of two NWs 200 and 500 nm in diameter. In the NW with $d = 200$ nm (left panel), the electric field penetrates into the nanowire in both cases, when $E \parallel \hat{z}$ (up) and in a small amount when $E \perp \hat{z}$ (down). In the case of a $d = 50$ nm NW, the electric field basically is zero inside the NW (panel right, down).

There is a second interesting paper,⁸³ where they calculate the polarized-Rayleigh backscattering signal instead of the complicated Raman signal, where we have to additionally take into account the Raman selection rules. Although unfortunately there are no explicit calculations (they refer to the original work of Rayleigh in 1881), they show that there are different resonances as a function of the NW diameter and also show the polar plots for a set of NWs, ranging from $d = 56$ to 560 nm. The results are in close agreement with the experimental results of the experiment performed by Xiong et al.⁸² Nevertheless, a complete quantum theoretical approach is still needed.

9 Conclusions

In this review paper, we have described the main topics related to Raman scattering in semiconductor NWs. After a revision of Raman scattering efficiency, we have found the selection

rules, in particular, for the two interesting cases of ZB and WZ materials. We have summarized the theory of surface optical phonons, comparing the results including retardation effects and the simple expression found in the literature where retardation is neglected. This expression has been used incorrectly and many unphysical results have been obtained. We also studied the case of phonon confinement and the appearance of the SO modes starting in the $n = 1$ phonon; since in the case of $n = 0$ we have shown that even in the presence of a surface, LO and TO modes do not mix. Finally, we give a short description of the antenna effect, although more effort must be put in this direction in order to give explicit analytical expressions.

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References

1. C. M. Lieber, "Semiconductor nanowires: a platform for nanoscience and nanotechnology," *MRS Bulletin* **36**, 1052–1063 (2011).
2. P. Yang, R. Yan, and M. Fardy, "Semiconductor nanowire: what's next?," *Nano Lett.* **10**, 1529–1536 (2010).
3. V. S. Pribiag et al., "Electrical control of single hole spins in nanowire quantum dots," *Nat. Nanotechnol.* **8**, 170–174 (2013).
4. Y. J. Hwang et al., "Si/InGa_N core/shell hierarchical nanowire arrays and their photoelectrochemical properties," *Nano Lett.* **12**, 1678–1682 (2012).
5. J. Segura-Ruiz et al., "Optical studies of MBE-grown InN nanocolumns: evidence of surface electron accumulation," *Phys. Rev. B* **79**, 115305 (2009).
6. E. Gadret et al., "Valence-band splitting energies in wurtzite InP nanowires: photoluminescence spectroscopy and ab initio calculations," *Phys. Rev. B Condens. Matter Mater. Phys.* **82**, 125327 (2010).
7. T. Chiaramonte et al., "Kinetic effects in InP nanowire growth and stacking fault formation: the role of interface roughening," *Nano Lett.* **11**, 1934–1940 (2011).
8. J. Segura-Ruiz et al., "Direct observation of elemental segregation in InGa_N nanowires by X-ray nanoprobe," *Phys. Status Solidi Rapid Res. Lett.* **5**, 95–97 (2011).
9. A. Molina-Sánchez et al., "LDA + U and tight-binding electronic structure of InN nanowires," *Phys. Rev. B Condens. Matter Mater. Phys.* **82**, 165324 (2010).
10. M. T. Björk et al., "One-dimensional heterostructures in semiconductor nanowhiskers," *Appl. Phys. Lett.* **80**, 1058–1061 (2002).
11. A. Hernández-Mínguez et al., "Acoustically Driven Photon Antibunching in Nanowires," *Nano Lett.* **12**, 252–258 (2012).
12. M. de Lima, Jr. et al., "Phonon-induced optical superlattice," *Phys. Rev. Lett.* **94**, 126805 (2005).
13. M. Möller et al., "Optical emission of InAs nanowires," *Nanotechnology* **23**, 375704 (2012).
14. M. Möller et al., "Polarized and resonant Raman spectroscopy on single InAs nanowires," *Phys. Rev. B Condens. Matter Mater. Phys.* **84**, 085318 (2011).
15. L. C. O. Dacal and A. Cantarero, "Structural, electronic and optical properties of InAs in the wurtzite phase," *Eur. Phys. Lett.* arXiv:1310.5652 [cond-mat.mes-hall], submitted.
16. L. C. O. Dacal and A. Cantarero, "Ab initio electronic band structure calculation of InP in the wurtzite phase," *Solid State Commun.* **151**, 781–784 (2011).
17. A. Molina-Sánchez et al., "Inhomogeneous electron distribution in InN nanowires: influence on the optical properties," *Phys. Status Solidi (C) Curr. Top. Solid State Phys.* **9**, 1001–1004 (2012).
18. J. Segura-Ruiz et al., "Inhomogeneous free-electron distribution in InN nanowires: photoluminescence excitation experiments," *Phys. Rev. B Condens. Matter Mater. Phys.* **82**, 125319 (2010).

19. T. Richter et al., “Electrical transport properties of single undoped and n-type doped InN nanowires,” *Nanotechnology* **20**, 405206 (2009).
20. V. Belitsky et al., “Elastic light scattering from semiconductor structures: Localized versus propagating intermediate electronic excitations,” *Phys. Rev. B* **52**, 16665–16675 (1995).
21. M. Gurioli et al., “Resonant Rayleigh scattering in quantum well structures,” *Solid State Commun.* **97**, 389–394 (1996).
22. A. Smekal, “Zur Quantentheorie der dispersion,” *Naturwissenschaften* **11**, 873–875 (1923).
23. G. Landsberg and L. Mandelstam, “Über die Lichtzerstreuung in Kristallen,” *Zeitschrift für Physik* **50**, 769–780 (1928).
24. C. V. Raman and K. S. Krishnan, “A new type of secondary radiation,” *Nature* **121**, 501 (1928).
25. L. Mandelstam, G. Landsberg, and M. Leontowitsch, “Über die Theorie der molekularen Lichtzerstreuung in Kristallen (klassische Theorie),” *Z. Physik* **60**, 334–344 (1930).
26. I. Tamm, “Über die Quantentheorie der molekularen Lichtzerstreuung in festen Körpern,” *Z. Physik* **60**, 345–363 (1930).
27. M. Born and K. Huang, *Dynamical Theory of Crystal Lattices*, International series of monographs on physics, Oxford University Press, Oxford (UK) (1954).
28. A. Cantarero, C. Trallero-Giner, and M. Cardona, “Excitons in one-phonon resonant Raman scattering: deformation-potential interaction,” *Phys. Rev. B* **39**, 8388–8397 (1989).
29. A. Cantarero, C. Trallero-Giner, and M. Cardona, “Excitons in one-phonon resonant Raman scattering: Fröhlich and interference effects,” *Phys. Rev. B* **40**, 12290–12295 (1989).
30. C. Trallero-Giner, A. Cantarero, and M. Cardona, “One-phonon resonant Raman scattering: Fröhlich exciton-phonon interaction,” *Phys. Rev. B* **40**, 4030–4036 (1989).
31. R. Loudon, “The Raman effect in crystals,” *Adv. Phys.* **13**, 423–482 (1964).
32. A. Alexandrou et al., “Theoretical model of stress-induced triply resonant Raman scattering,” *Phys. Rev. B* **40**, 1603–1610 (1989).
33. M. Kuball et al., “Electric-field-induced Raman scattering in GaAs: Franz-Keldysh oscillations,” *Phys. Rev. B* **51**, 7353–7356 (1995).
34. T. Ruf et al., “Resonant Raman scattering and piezomodulated reflectivity of InP in high magnetic fields,” *Phys. Rev. B* **39**, 13378–13388 (1989).
35. J. Camacho et al., “Vibrational properties of ZnTe at high pressures,” *J. Phys. Condens. Matter* **14**, 739–757 (2002).
36. A. García-Cristóbal et al., “Excitonic model for second-order resonant Raman scattering,” *Phys. Rev. B* **49**, 13430–13445 (1994).
37. D. Olguín, M. Cardona, and A. Cantarero, “Electron-phonon effects on the direct band gap in semiconductors: LCAO calculations,” *Solid State Commun.* **122**, 575–589 (2002).
38. A. Cantarero et al., “Transport properties of bismuth sulfide single crystals,” *Phys. Rev. B* **35**, 9586–9590 (1987).
39. D. Tenne et al., “Probing nanoscale ferroelectricity by ultraviolet Raman spectroscopy,” *Science* **313**, 1614–1616 (2006).
40. M. V. Klein, *Light Scattering in Solids I, Topics in Applied Physics*, M. Cardona, Ed., Springer, Germany (1983).
41. V. Belitsky et al., “Feynman diagrams and Fano interference in light scattering from doped semiconductors,” *J. Phys. Condens. Matter* **9**, 5965–5976 (1997).
42. F. Widulle et al., “Raman studies of isotope effects in Si and GaAs,” *Phys. B: Condens. Matter* **263–264**, 381–383 (1999).
43. N. Garro et al., “Electron-phonon interaction at the direct gap of the copper halides,” *Solid State Commun.* **98**, 27–30 (1996).
44. J. Serrano et al., “Raman scattering in β -ZnS,” *Phys. Rev. B* **69**, 014301 (2004).
45. R. Tallman et al., “Pressure measurements of TO-phonon anharmonicity in isotopic ZnS,” *Phys. Status Solidi B-Basic Res.* **241**, 491–497 (2004).
46. C. Ulrich et al., “Vibrational properties of InSe under pressure: experiment and theory,” *Phys. Status Solidi B Basic Solid State Phys.* **198**, 121–127 (1996).

47. G. H. Li et al., "Photoluminescence from strained InAs monolayers in GaAs under pressure," *Phys. Rev. B* **50**, 1575–1581 (1994).
48. E. Anastassakis, A. Cantarero, and M. Cardona, "Piezo-Raman measurements and anharmonic parameters in silicon and diamond," *Phys. Rev. B* **41**, 7529–7535 (1990).
49. H. Kuzmany, *Solid-State Spectroscopy: An Introduction*, Springer Verlag, Germany (1998).
50. A. Cantarero, *Encyclopedia of Nanotechnology*, B. Bhushan, Ed., Springer, Germany (2012).
51. W. Trzeciakowski, J. Martinez Pastor, and A. Cantarero, "High accuracy Raman measurements using the Stokes and anti-Stokes lines," *J. Appl. Phys.* **82**, 3976–3982 (1997).
52. M. Cardona, *Light Scattering in Solids II, Topics in Applied Physics*, M. Cardona and G. Güntherodt, Eds., Springer, Germany (1982).
53. D. L. Rousseau, R. P. Bauman, and P. S. S. Porto, "Normal mode determination in crystals," *J. Raman Spectrosc.* **10**, 253–290 (1981).
54. A. K. Ganguly and J. L. Birman, "Theory of lattice Raman scattering in insulators," *Phys. Rev.* **162**, 806–816 (1967).
55. K. T. Tsen et al., "Subpicosecond time-resolved Raman studies of LO phonons in GaN: dependence on photoexcited carrier density," *Appl. Phys. Lett.* **89**, 112111 (2006).
56. G. Bir and G. Pikus, *Symmetry and Strain-Induced Effects in Semiconductors*, John Wiley & Sons Inc., New York (1974).
57. C. Trallero-Giner et al., "Impurity-induced resonant Raman scattering," *Phys. Rev. B* **45**, 6601–6613 (1992).
58. G. Irmer, "Local crystal orientation in III-V semiconductors: polarization selective Raman microprobe measurements," *J. Appl. Phys.* **76**, 7768–7773 (1994).
59. C. A. Arguello, D. L. Rousseau, and P. S. S. Porto, "First-order Raman effect in wurtzite-type crystals," *Phys. Rev.* **181**, 1351–1363 (1969).
60. R. Ruppini and R. Englman, "Optical phonons of small crystals," *Rep. Prog. Phys.* **33**, 149–196 (1970).
61. T. Sander et al., "Raman tensor elements of wurtzite ZnO," *Phys. Rev. B* **85**, 165208 (2012).
62. Y. Zhao et al., "Phonons in Bi₂S₃ nanostructures: Raman scattering and first-principles studies," *Phys. Rev. B* **84**, 205330 (2011).
63. C. de Tomás et al., "Lattice thermal conductivity of silicon nanowires," *J. Thermoelectr.* **2013**, 11–18 (2013).
64. C. Kittel, *Quantum Theory of Solids*, Wiley, New York (1963).
65. N. Marschall and B. Fischer, "Dispersion of Surface Polaritons in GaP," *Phys. Rev. Lett.* **28**, 811–813 (1972).
66. N. Ashkenov et al., "Infrared dielectric functions and phonon modes of high-quality ZnO films," *J. Appl. Phys.* **93**, 126–133 (2003).
67. G. B. Arfken, H. J. Weber, and F. E. Harris, *Mathematical Methods for Physicists: A Comprehensive Guide*, 7th Ed., Academic Press, Elsevier, Amsterdam (2012).
68. G. Cincotti et al., "Plane wave expansion of cylindrical functions," *Opt. Commun.* **95**, 192–195 (1993).
69. R. Gupta et al., "Surface optical phonons in GaP nanowires," *Nano Lett.* **3**, 1745–1750 (2003).
70. B. Sernelius, *Surface Modes in Physics*, John Wiley & Sons Incorporated, Berlin, Germany (2001).
71. M. Abramowitz and I. A. Stegun, *Handbook of Mathematical Functions with Formulas, Graphs, and Mathematical Tables*, Dover, New York (1964).
72. P. Yu and M. Cardona, *Fundamentals of Semiconductors: Physics and Materials Properties*, Springer, Berlin, Heidelberg (2010).
73. R. Englman and R. Ruppini, "Optical lattice vibrations in finite ionic crystals: III," *J. Phys. C* **1**, 1515–1531 (1968).
74. F. Comas, C. Trallero-Giner, and A. Cantarero, "Optical phonons and electron-phonon interaction in quantum wires," *Phys. Rev. B* **47**, 7602–7605 (1993).

75. F. Comas et al., “Polar optical oscillations in quantum wires and free-standing wires: the electron-phonon interaction Hamiltonian,” *J. Phys. Condens. Matter* **7**, 1789–1805 (1995).
76. Z. Li, “Polar oscillation of interface and surface optical phonons in free-standing cylindrical quantum-well wires,” *Commun. Theor. Phys.* **42**, 459–466 (2004).
77. H. Fröhlich, *Theory of Dielectrics, Monographs on the Physics, and Chemistry of Materials*, B. Chalmers et al., Eds., Clarendon Press, Oxford (1952).
78. Y. F. Zhang et al., “Germanium nanowires sheathed with an oxide layer,” *Phys. Rev. B* **61**, 4518–4521 (2000).
79. G. Faraci et al., “Quantum size effects in Raman spectra of Si nanocrystals,” *J. Appl. Phys.* **109**, 074311 (2011).
80. G. Duesberg et al., “Polarized Raman spectroscopy on isolated single-wall carbon nanotubes,” *Phys. Rev. Lett.* **85**, 5436–5439 (2000).
81. H. Ajiki and T. Ando, “Carbon nanotubes: optical absorption in Aharonov-Bohm flux,” *Jpn. J. Appl. Phys. 2, Lett.* **34**, 107–109 (1994).
82. Q. Xiong et al., “Raman scattering studies of individual polar semiconducting nanowires: phonon splitting and antenna effects,” *Appl. Phys. A* **85**, 299–305 (2006).
83. D. Zhang et al., “Polarized Rayleigh back-scattering from individual semiconductor nanowires,” *Nanotechnology* **21**, 315202 (2010).

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